

ABHINAV ACADEMY

UDUPI

CET25P14 ELECTRONIC DEVICES

Class 12 - Physics

Time Allowed: 1 hour and 30 minutes

Maximum Marks: 75

| 1. | In n-type semiconductor when all donor states are fill | ed, then the net charge density in the donor states becomes: | [1] |
|----|--|--|-----|
| | a) < 1, but not zero | b) > 1 | |
| | c) 1 | d) zero | |
| 2. | Distance between body centred atom and a corner ato | m in sodium (a = $4.225 \stackrel{o}{A}$) is | [1] |
| | a) _{2.54} Å | b) 3.17 Å | |
| | c) _{3.66} Å | d) _{2.99} Å | |
| 3. | The example of p-type semiconductor is | | [1] |
| | a) germanium doped with arsenic | b) pure germanium | |
| | c) germanium doped with boron | d) pure silicon | |
| 4. | A half wave rectifier is being used to rectify an altern | ating voltage of frequency 50 Hz. The number of pulses of | [1] |
| | rectified current obtained in one second is | Y | |
| | a) 50 Hz | b) 200 Hz | |
| | c) 100 Hz | d) 25 Hz | |
| 5. | The valence electron in an alkali metal is a | | [1] |
| | a) s-electron | b) p-electron | |
| | c) d-electron | d) f-electron | |
| 6. | In an extrinsic semiconductor, the number density of | holes is 4 $	imes$ 10 ²⁰ m ⁻³ . If the number density of intrinsic | [1] |
| | carriers is $1.2 	imes 10^{15}$ m ⁻³ , the number density of electron | trons in it is | |
| | a) $2.4 \times 10^{10} \text{ m}^{-3}$ | b) $3.2 \times 10^{10} \text{ m}^{-3}$ | |
| | c) $1.8 \times 10^9 \text{m}^{-3}$ | d) $3.6 \times 10^9 \text{m}^{-3}$ | |
| 7. | Photo diodes are used to detect | | [1] |
| | a) IR rays | b) radio waves | |
| | c) optical signals | d) gamma rays | |
| 8. | At a certain temperature in an intrinsic semiconductor | r, the electrons and holes concentration is $1.5	imes10^{16}{ m m}^{-3}$. | [1] |
| | When it is doped with a trivalent dopant, hole concen | tration increases to 4.5 $	imes$ 10 ²² m ⁻³ . In the doped | |
| | semiconductor, the concentration of electrons (n_e) will | l be: | |

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| | $5	imes10^9\mathrm{m}^{-3}$ | $3	imes10^6\mathrm{m}^{-3}$ | |
|-----|--|---|-----|
| | c) $5 \times 10^7 \text{m}^{-3}$ | d) $6.75 \times 10^{38} \mathrm{m}^{-3}$ | |
| 9. | Carbon (C), silicon (Si) and germanium (Ge) have for of the following statements is most appropriate? | ur valence electrons each. At room temperature, which one | [1] |
| | a) The number of free conduction electrons is significant only in Si, but small in C. | b) The number of free conduction electrons is significant in C, but small in Si and Ge. | |
| | c) The number of free conduction electrons is significant in all the three. | d) The number of free conduction electrons is negligible in all the three. | |
| 10. | The relation between the forward current \mathbf{I}_{f} and saturate | ation current I _s for p-n junction diode is: | [1] |
| | a) $I_f I_s = 1$ | b) $I_f = I_s$ | |
| | C) $I_f = I_s \left[rac{qV}{KT} - 1 ight]$ | d) $I_f = I_s e^{(qV/KT)-1}$ | |
| 11. | Diode is used as a/an | | [1] |
| | a) rectifier | b) amplifier | |
| | c) modulator | d) oscillator | |
| 12. | In an n-type semiconductor, the donor energy level lie | es | [1] |
| | a) in the conduction band | b) just below the conduction band | |
| | c) just above the valance band | d) at the center of the energy gap | |
| 13. | The resistivity of a semiconductor at room temperature | re is in between: | [1] |
| | a) 10^{-3} to $10^6 \Omega$ cm | b) 10^{10} to $10^{12} \Omega$ cm | |
| | c) 10^{-2} to $10^{-5} \Omega$ cm | d) 10^6 to $10^8~\Omega$ cm | |
| 14. | An intrinsic semiconductor, at the absolute zero temp | erature, behaves like a/an | [1] |
| | a) insulator | b) superconductor | |
| | c) n-type semiconductor | d) p-type semiconductor | |
| 15. | | veen the bottom of the conduction band E_{C} and the donor | [1] |
| | energy level E_D is of the order of: | | |
| | a) 0.01 eV | b) 10 eV | |
| | c) 1 eV | d) 0.1 eV | |
| 16. | Forward biasing of p-n junction offers | | [1] |
| | a) zero resistance | b) high resistance | |
| | c) infinite resistance | d) low resistance | |
| 17. | 12 V battery is applied in forward bias across a circui | | [1] |
| | potential is dropped across the p-n junction, and curre | ent is 2 $	imes$ 10 ⁻³ A. The resistance R is | |
| | a) 5.7 $	imes$ 10 ⁴ Ω | b) 5.7×10^{3} | |
| | c) 5.7 $	imes$ 10 ² Ω | d) 5.7×10^5 | |

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| 18. | For forward biasing a p-n junction, the positive terminal | of the battery is connected to | [1] |
|-----|--|--|-----|
| | a) n-type crystal | b) either p-type or n-type crystal | |
| | c) p-type crystal | l) neither p-type nor n-type crystal | |
| 19. | The energy gap between the valence and conduction bar | nds of a substance is 6 eV. The substance is a: | [1] |
| | a) semiconductor | b) superconductor | |
| | c) insulator | l) conductor | |
| 20. | Suitable impurities are added to a semiconductor depend | ling upon its use. This is done to | [1] |
| | a) increase its electrical resistivity | o) enable it to withstand high voltage | |
| | c) increase its electrical conductivity | l) increase its life | |
| 21. | Which of the following is the weakest kind of bonding is | n solids? | [1] |
| | a) Van der Waals b | b) Covalent | |
| | c) Metallic | d) Ionic | |
| 22. | When an intrinsic semiconductor is doped with a small a | amount of trivalent impurity, then: | [1] |
| | a) its resistance increases. | o) it becomes a p-type semiconductor. | |
| | c) there will be more free electrons than holes | d) dopant atoms become donor atoms. | |
| | in the semiconductor. | | |
| 23. | A p-n junction diode is connected to a battery of emf 5.5 | 5 V and external resistance 5.1 k Ω . The barrier potential | [1] |
| | in the diode is 0.4 V. The current in the circuit is: $5.1k\Omega$ | | |
| | | Y | |
| | | | |
| | | | |
| | 5.5 V | | |
| | a) 1 mA t | b) 1.08 mA | |
| | c) 0.08 mA | l) 1 A | |
| 24. | In p-type semiconductor, | | [1] |
| | A. major current carrier are electrons | | |
| | B. major carrier are mobile negative ions | | |
| | C. major carrier are mobile holes | | |
| | D. the number of mobile holes exceeds the number of a | cceptor atoms | |
| | a) Option C b | b) Option A | |
| | c) Option D | l) Option B | |
| 25. | When trivalent impurity is mixed in a pure semiconduct | or, the conduction is mainly due to | [1] |
| | a) holes b | b) protons | |
| | c) positive ions | l) electrons | |
| 26. | In a good conductor, the energy gap between the valence | e and conduction bands is | [1] |

| | a) infinite | b) 6 eV | |
|-----|---|---|-----|
| | c) zero | d) 1 eV | |
| 27. | Which one of the following elements will require the | e highest energy to take out an electron from them? | [1] |
| | Pb, Ge, C and Si | | |
| | a) C | b) Ge | |
| | c) Pb | d) Si | |
| 28. | Holes are charge carriers in | | [1] |
| | a) intrinsic and p-type semiconductors | b) n-type semiconductor | |
| | c) intrinsic semiconductor only | d) p-type semiconductor only | |
| 29. | The dominant mechanisms, due to the concentration | gradient, for motion of charge carriers in silicon p-n | [1] |
| | junction are: | | |
| | a) Diffusion of holes from p to n and electrons from n to p | b) Diffusion of electrons only from n to p | |
| | c) Diffusion of holes only from p to n | d) Diffusion of holes from n to p and electrons from p to n | |
| 30. | The unidirectional flow of current through p-n juncti | on makes it ideal to be used as | [1] |
| | a) photoelectricity | b) modulator | |
| | c) oscillator | d) rectifier | |
| 31. | In a middle of the depletion layer of a reverse biased | p-n junction, the | [1] |
| | a) electric field is maximum | b) potential is zero | |
| | c) potential is maximum | d) electric field is zero | |
| 32. | The potential barrier in the depletion layer is due to | | [1] |
| | a) Holes | b) Forbidden gap | |
| | c) Electrons | d) Ions | |
| 33. | The intrinsic semiconductor becomes an insulator at: | : | [1] |
| | a) -100 C | b) 300 K | |
| | c) 0 C | d) 0 K | |
| 34. | A solid having uppermost energy band partially filled | d with electrons is called | [1] |
| | a) non-metal | b) semi-conductor | |
| | c) insulator | d) conductor | |
| 35. | A p-type semiconductor can be obtained by adding | | [1] |
| | a) phosphorus to pure germanium | b) gallium to pure silicon | |
| | c) arsenic to pure silicon | d) antimony to pure germanium | |
| 36. | If n_e and n_h are the number of electrons and holes in | pure germanium, then | [1] |
| | a) $n_e = finite and n_h = 0$ | b) $n_e = n_h$ | |

| | c) n _e < n _h | d) $n_e > n_h$ | |
|-----|---|--|-----|
| 37. | Semiconductors behave like insulators at | | [1] |
| | a) 273 K | p) 0 ₀ C | |
| | c) 0 K | d) 300 K | |
| 38. | In semiconducting materials, the mobilities of electrist is true? | rons and holes are μ_e and μ_h respect. Which of the following | [1] |
| | a) $\mu_e=\mu_h$ | b) $\mu_e > \mu_h$ | |
| | c) $\mu_e < 0; \mu_h > 0$ | d) $\mu_e < \mu_h$ | |
| 39. | The impurity atoms to be mixed in pure silicon to for | orm p-type semiconductor are, of | [1] |
| | a) aluminum | b) phosphorus | |
| | c) germanium | d) antimony | |
| 40. | In a reverse-biased p-n junction, when the applied b | ias voltage is equal to the breakdown voltage, then | [1] |
| | a) current remains constant while voltage increases sharply | b) voltage remains constant while current increases sharply | |
| | c) current and voltage decrease | d) current and voltage increase | |
| 41. | If a p-n diode is reverse biased, then the resistance r | neasured by an ohmmeter will be | [1] |
| | a) low | b) infinite | |
| | c) zero | d) high | |
| 42. | In the depletion region of an unbiased p-n junction | diode, there are | [1] |
| | a) immobile ions | b) electrons | |
| | c) mobile ions | d) holes | |
| 43. | In an unbiased p-n junction, | | [1] |
| | a) undetermined | b) high potential at n side and low potential at p side | |
| | c) p and n both are at same potential | d) high potential at p side and low potential at n side | |
| 44. | The output from a full wave rectifier is | | [1] |
| | a) a pulsating unidirectional voltage | b) a dc voltage | |
| | c) zero | d) unidirectional voltage having ripples | |
| 45. | Number of atoms per unit cell in bcc lattice is | , 0 0 H | [1] |
| | a) 9 | b) 2 | |
| | c) 4 | d) 1 | |
| 46. | In forward bias, the width of a potential barrier in a | | [1] |
| | a) remains constant | b) increases | |
| | | | |
| | c) decreases | d) first remains constant then decreases | |

| 47. | Current through the ideal diode is: 100Ω | | [1] |
|-----|--|---|-----|
| | 2V 5V | | |
| | ÷ ÷ | | |
| | a) 20 A | b) $(\frac{1}{20})$ A | |
| | c) zero | d) $(\frac{1}{50})$ A | |
| 48. | The number of valence electrons in a good conducto | r is generally | [1] |
| | a) three or less than three | b) four | |
| | c) six or more than six | d) five | |
| 49. | A donor impurity results in | | [1] |
| | a) increase of resistance of the semiconductor | b) production of n-semiconductor | |
| | c) energy bands just above the filled valency | d) production of p-semiconductor | |
| 50. | Rectification is the process of conversion of | | [1] |
| | a) low d.c. into high d.c. | b) low a.c. into high a.c. | |
| | c) a.c. into d.c. | d) d.c. into a.c. | |
| 51. | The difference in variation of resistance with temper | rature in a metal and semiconductor is due to | [1] |
| | a) type of bonding | b) variation of scattering with temperature | |
| | c) variation in number of charge carries with temperature | d) crystal structure | |
| 52. | In a p-type semiconductor, the majority carriers of c | urrent are | [1] |
| | a) electrons | b) neutrons | |
| | c) holes | d) protons | |
| 53. | When a forward bias is applied to a p-n junction, it | | [1] |
| | a) reduces the majority carrier current to zero | b) lowers the potential barrier | |
| | c) free electrons and holes move away from | d) raises the potential barrier | |
| 54. | the juction Atomic packing factor of simple cubic cell is | | [1] |
| 54. | | L) π | [+] |
| | a) $\frac{\pi}{6}$ | b) $\frac{\pi}{8}$ d) $\pi \frac{\sqrt{3}}{8}$ | |
| | c) $\frac{\pi}{3\sqrt{2}}$ | 0 | [4] |
| 55. | Energy required to break one bond in DNA is approx | - | [1] |
| | a) $\approx 2.1 \mathrm{eV}$ | b) $\approx 1 \mathrm{eV}$ | |
| | c) $\approx 0.1 \text{eV}$ | d) $\approx 0.01 \mathrm{eV}$ | |
| 56. | Forbidden energy gap for a diamond is about: | | [1] |
| | a) 1.5 eV | b) 6 eV | |
| | c) 1 eV | d) 0.6 eV | |

| 57. | Energy gap between valence band and conduction band of a semiconductor is | | [1] |
|-----|---|--|-----|
| | a) infinite | b) zero | |
| | c) 10 eV | d) 1 eV | |
| 58. | The formation of depletion region in a p-n junction d | iode is due to | [1] |
| | a) movement of dopant atoms | b) drift of electrons only | |
| | c) diffusion of both electrons and holes | d) drift of holes only | |
| 59. | An n-type Ge is obtained on doping the Ge-crystal w | ith | [1] |
| | a) phosphorus | b) gold | |
| | c) aluminum | d) boron | |
| 60. | The cause of the potential barrier in a p-n diode is | | [1] |
| | a) depletion of positive charges near the | b) the concentration of positive and negative | |
| | junction | charges near the junction | |
| | c) concentration of positive charges near the junction | d) depletion of negative charges near the junction | |
| 61. | The probability of finding an electron in Fermi energ | y level is: | [1] |
| | a) 50% | b) 20% | |
| | c) 0% | d) 100% | |
| 62. | The state of energy gained by valence electrons when applied is called | the temperature is raised or when an electric field is | [1] |
| | a) valence band | b) non valence band | |
| | c) conduction band | d) forbidden band | |
| 63. | In a p-type semiconductor, germanium is doped with | | [1] |
| | a) aluminium | b) all of these | |
| | c) gallium | d) boron | |
| 64. | The energy gap between the conduction band and val | ence band is of the order of 0.07 eV. It is a/an | [1] |
| | a) insulator | b) semiconductor | |
| | c) conductor | d) alloy | |
| 65. | During the formation of a p-n junction: | | [1] |
| | a) both the diffusion current and drift current remain constant. | b) diffusion current keeps increasing. | |
| | c) diffusion current remains almost constant but drift current increases till both currents become equal. | d) drift current remains constant. | |
| 66. | For the forward biasing of a p-n junction diode, whic | h of the following statements is not correct? | [1] |
| | a) Forward current is due to the diffusion of both holes and electrons. | b) Minority carrier injection occurs. | |

| | c) The potential barrier decreases. | d) Width of depletion layer increases. | |
|-------------|--|---|-----|
| 67. | At equilibrium, in a p-n junction diode the net current | is | [1] |
| | a) due to drift of minority charge carriers | b) due to diffusion of majority charge carriers | |
| | c) zero as diffusion and drift currents are equal and opposite | d) zero as no charge carriers across the junction | |
| 68. | The behavior of Ge as a semiconductor is due to the v | vidth of | [1] |
| | a) forbidden band being small and narrow | b) forbidden band being large and wide | |
| | c) conduction band being small and narrow | d) conduction band being large | |
| 69. | The electrical conductivity of a semiconductor increas | ses when electromagnetic radiation of wavelength shorter | [1] |
| | than 2480 nm is incident on it. The band gap (in eV) f | for the semi conductor is: | |
| | a) 1.1 | b) 0.9 | |
| | c) 0.7 | d) 0.5 | |
| 70. | The typical ionization energy of a donor in silicon is | | [1] |
| | a) 1.0 eV | b) 10.0 eV | |
| | c) 0.001 eV | d) 0.1 eV | |
| 71. | A Ge specimen is doped with Al. The concentration o | of acceptor atoms is $pprox 10^{21}$ atoms m ⁻³ . Given that the | [1] |
| | intrinsic concentration of electron-hole pair is $pprox 10^{19}$ | m ⁻³ , the concentration of electrons in the specimen is | |
| | a) 10 ¹⁷ m ⁻³ | b) $10^2 \mathrm{m}^{-3}$ | |
| | c) 10^{15} m^{-3} | d) 10^4 m^{-3} | |
| 72. | In n-type semiconductors, majority charge carriers are | | [1] |
| | a) holes | b) protons | |
| | c) electrons | d) neutrons | |
| 73. | C and Si both have the same lattice structure, having | 4 bonding electrons in each. However, C is an insulator | [1] |
| | whereas Si is an intrinsic semiconductor. This is beca | use | |
| | A. In case of C the valence band is not completely fil | - | |
| | B. In case of C the conduction band is partly filled ev | | |
| | C. The four bonding electrons in the case of C lie in t third. | the second orbit, whereas in the case of Si they lie in the | |
| | | the third orbit, whereas for Si they lie in the fourth orbit. | |
| | a) Option B | b) Option A | |
| | | | |
| 74. | c) Option D A p-n junction has a thickness of the order of | d) Option C | [1] |
| , . | | b) 1 mm | [1] |
| | a) 1 cm | b) 1 mm | |
| _ | c) 10 ⁻⁶ m | d) 10^{-12} cm | [1] |
| 75. | Sodium has body-centered packing. If the distance be | tween two nearest atoms is 3.7 $\overset{\mathrm{o}}{\mathrm{A}}$, then lattice parameter is | [1] |

| a) 3.3 Å | b) $_{3.9}{ m \overset{o}{A}}$ |
|---------------------|-------------------------------------|
| c) _{4.8} Å | d) $_{4.3}{ m \mathring{A}}^{ m o}$ |

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